

August 2010

# PN2222A / MMBT2222A / PZT2222A NPN General Purpose Amplifier

### **Features**

- This device is for use as a medium power amplifier and switch requiring collector currents up to 500mA.
- Sourced from process 19.



# Absolute Maximum Ratings \* T<sub>a</sub> = 25°C unless otherwise noted

Symbol	Parameter	Value	Units	
V <sub>CEO</sub>	Collector-Emitter Voltage	40	V	
V <sub>CBO</sub>	Collector-Base Voltage	75	V	
V <sub>EBO</sub>	Emitter-Base Voltage	6.0	V	
I <sub>C</sub>	Collector Current	1.0	А	
T <sub>STG</sub>	Operating and Storage Junction Temperature Range	- 55 ~ 150	°C	

<sup>\*</sup> This ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

- 1) These rating are based on a maximum junction temperature of 150 degrees C.
- 2) These are steady limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

## Thermal Characteristics T<sub>a</sub> = 25°C unless otherwise noted

Symbol	Parameter	Max.			Units
		PN2222A	*MMBT2222A	**PZT2222A	Ullits
P <sub>D</sub>	Total Device Dissipation Derate above 25°C	625 5.0	350 2.8	1,000 8.0	mW mW/°C
$R_{ heta JC}$	Thermal Resistance, Junction to Case	83.3			°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient	200	357	125	°C/W

<sup>\*</sup> Device mounted on FR-4 PCB 1.6"  $\times$  1.6"  $\times$  0.06".

<sup>\*\*</sup> Device mounted on FR-4 PCB 36mm imes 18mm imes 1.5mm; mounting pad for the collector lead min. 6cm $^2$ .

# **Electrical Characteristics** $T_a = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Max.	Units
Off Charact	eristics			•	•
BV <sub>(BR)CEO</sub>	Collector-Emitter Breakdown Voltage *	$I_C = 10 \text{mA}, I_B = 0$	40		V
BV <sub>(BR)CBO</sub>	Collector-Base Breakdown Voltage	Collector-Base Breakdown Voltage $I_C = 10\mu A, I_E = 0$			V
BV <sub>(BR)EBO</sub>	Emitter-Base Breakdown Voltage	$I_E = 10\mu A, I_C = 0$	6.0		V
I <sub>CEX</sub>	Collector Cutoff Current	$V_{CE} = 60V, V_{EB(off)} = 3.0V$		10	nA
I <sub>CBO</sub>	Collector Cutoff Current	$V_{CB} = 60V, I_{E} = 0$ $V_{CB} = 60V, I_{E} = 0, T_{a} = 125^{\circ}C$		0.01 10	μA μA
I <sub>EBO</sub>	Emitter Cutoff Current	$V_{EB} = 3.0V, I_{C} = 0$		10	nA
I <sub>BL</sub>	Base Cutoff Current	$V_{CE} = 60V, V_{EB(off)} = 3.0V$		20	nA
On Charact	eristics				
h <sub>FE</sub>	DC Current Gain	$\begin{split} &I_{C} = 0.1 \text{mA},  V_{CE} = 10 \text{V} \\ &I_{C} = 1.0 \text{mA},  V_{CE} = 10 \text{V} \\ &I_{C} = 10 \text{mA},  V_{CE} = 10 \text{V} \\ &I_{C} = 10 \text{mA},  V_{CE} = 10 \text{V},  T_{a} = -55^{\circ}\text{C} \\ &I_{C} = 150 \text{mA},  V_{CE} = 10 \text{V} ^{*} \\ &I_{C} = 150 \text{mA},  V_{CE} = 1 \text{V} ^{*} \\ &I_{C} = 500 \text{mA},  V_{CE} = 10 \text{V} ^{*} \end{split}$	35 50 75 35 100 50 40	300	
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage *	$I_C = 150$ mA, $I_B = 15$ mA $I_C = 500$ mA, $I_B = 50$ mA		0.3 1.0	V V
V <sub>BE(sat)</sub>	Base-Emitter Saturation Voltage *	$I_C = 150$ mA, $I_B = 15$ mA $I_C = 500$ mA, $I_B = 50$ mA	0.6	1.2 2.0	V
Small Signa	al Characteristics				
f <sub>T</sub>	Current Gain Bandwidth Product	I <sub>C</sub> = 20mA, V <sub>CE</sub> = 20V, f = 100MHz	300		MHz
C <sub>obo</sub>	Output Capacitance	V <sub>CB</sub> = 10V, I <sub>E</sub> = 0, f = 1MHz		8.0	pF
C <sub>ibo</sub>	Input Capacitance	$V_{EB} = 0.5V, I_{C} = 0, f = 1MHz$		25	pF
rb'C <sub>c</sub>	Collector Base Time Constant	$I_C = 20$ mA, $V_{CB} = 20$ V, $f = 31.8$ MHz		150	pS
NF	Noise Figure	$I_C = 100\mu A$ , $V_{CE} = 10V$ , $R_S = 1.0K\Omega$ , $f = 1.0KHz$		4.0	dB
Re(h <sub>ie</sub> )	Real Part of Common-Emitter High Frequency Input Impedance	$I_C = 20$ mA, $V_{CE} = 20$ V, $f = 300$ MHz		60	Ω
Switching C	Characteristics			-	•
t <sub>d</sub>	Delay Time	$V_{CC} = 30V, V_{EB(off)} = 0.5V,$		10	ns
t <sub>r</sub>	Rise Time	I <sub>C</sub> = 150mA, I <sub>B1</sub> = 15mA		25	ns
t <sub>s</sub>	Storage Time	V <sub>CC</sub> = 30V, I <sub>C</sub> = 150mA,		225	ns
t <sub>f</sub>	Fall Time	$I_{B1} = I_{B2} = 15 \text{mA}$		60	ns

<sup>\*</sup> Pulse Test: Pulse Width  $\leq 300 \mu s, \, Duty \, Cycle \leq 2.0\%$ 

# **Typical Performance Characteristics**

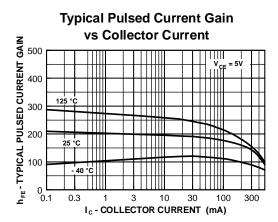


Figure 1. Typical Pulsed Current Gain vs Collector Current

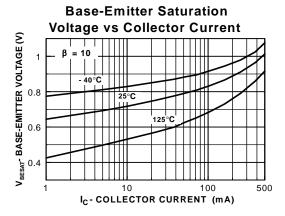


Figure 3. Base-Emitter Saturation Voltage vs Collector Current

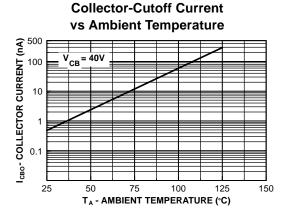


Figure 5. Collector Cutoff Current vs Ambient Temperature

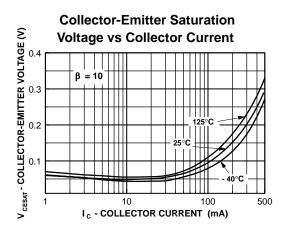


Figure 2. Collector-Emitter Saturation Voltage vs Collector Current

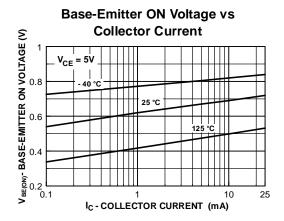


Figure 4. Base-Emitter On Voltage vs Collector Current

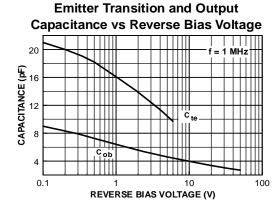


Figure 6. Emitter Transition and Output Capacitance vs Reverse Bias Voltage

# **Typical Performance Characteristics**

# Turn On and Turn Off Times vs Collector Current

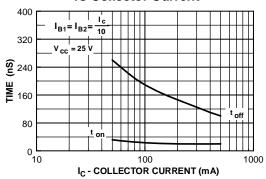


Figure 7. Turn On and Turn Off Times vs Collector Current

### Power Dissipation vs Ambient Temperature

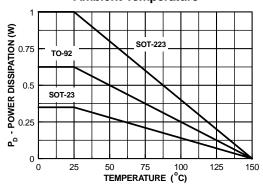


Figure 9. Power Dissipation vs Ambient Temperature

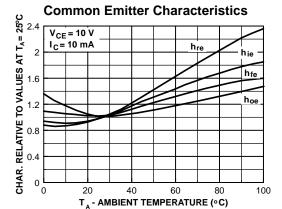


Figure 11. Common Emitter Characteristics

### (Continued)

# Switching Times vs Collector Current

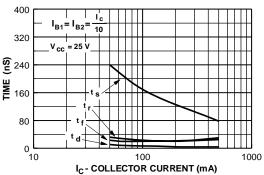


Figure 8. Switching Times vs Collector Current

### **Common Emitter Characteristics**

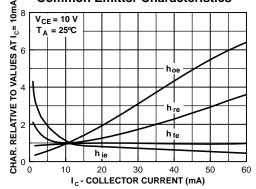


Figure 10. Common Emitter Characteristics

### **Common Emitter Characteristics**

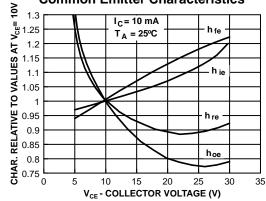


Figure 12. Common Emitter Characteristics





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